



Title: IMPROVING SEM INSPECTION AND ANALYSIS OF PATTERNED PHOTORESIST FEATURES
Inventor(s): Uzodinma Okoroanyanwu et al.
Appl. NO.: 09 / 820, 143

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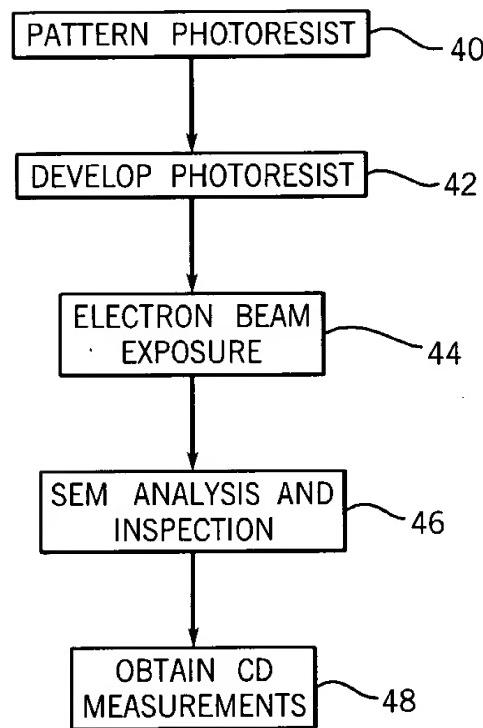


FIG. 1



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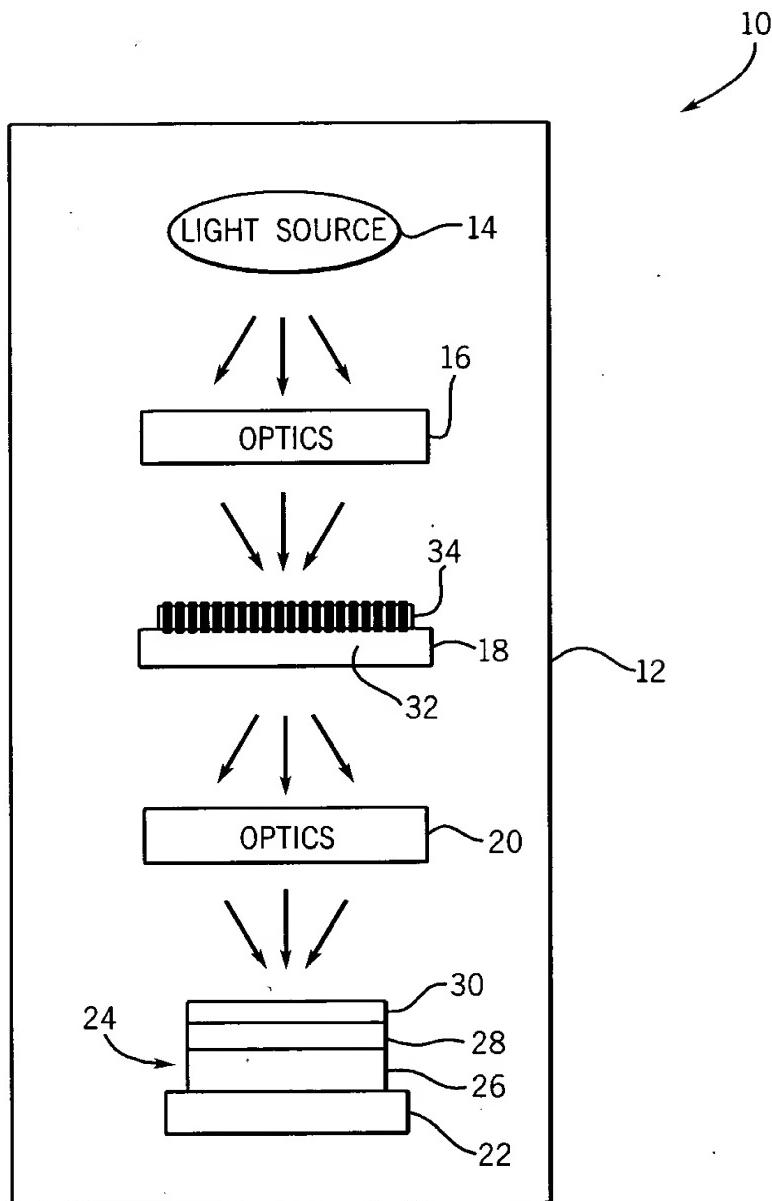


FIG. 2



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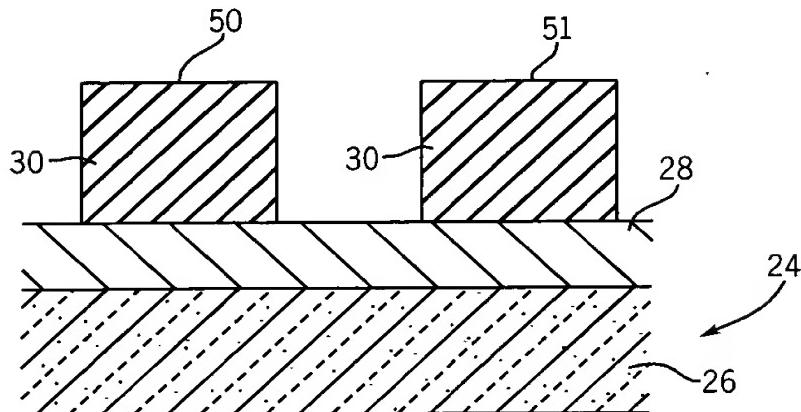


FIG. 3

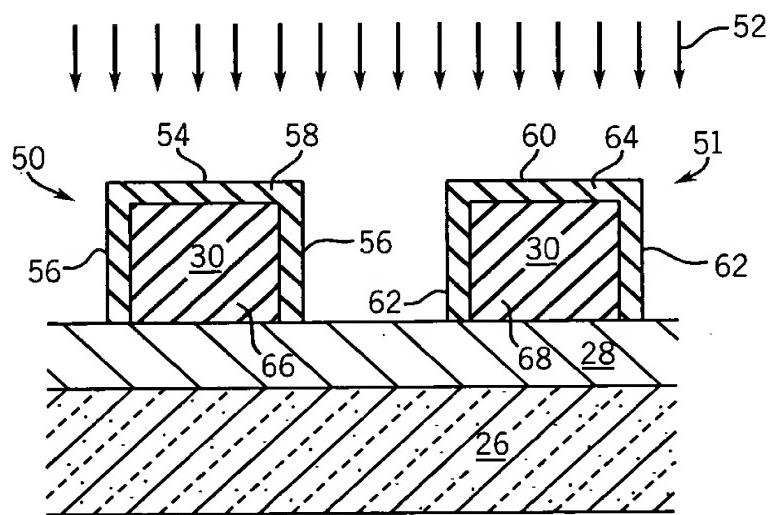


FIG. 4



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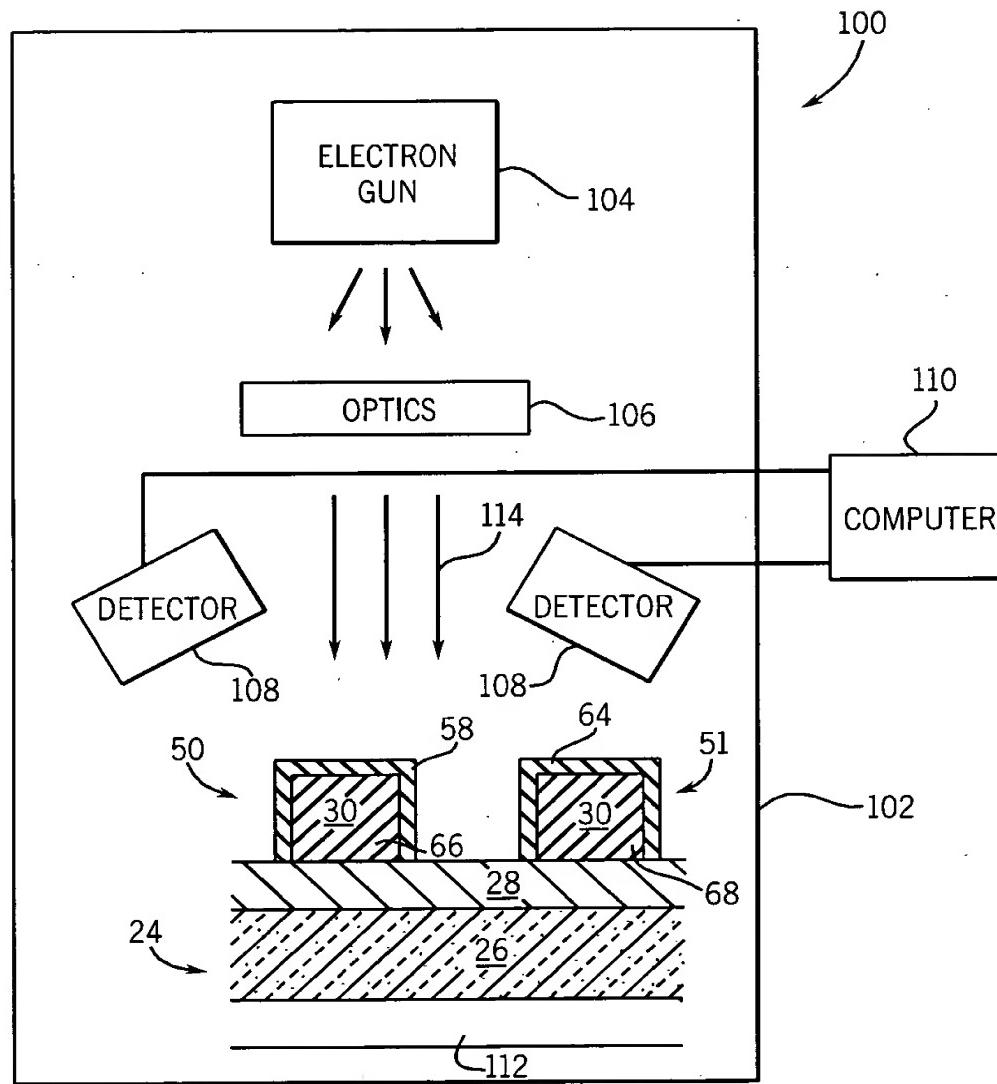


FIG. 5